

<b>Notice of References Cited</b>	Application/Control No. 09/716,227	Applicant(s)/Patent Under Reexamination KWON ET AL.	
	Examiner Kieu D. Vu	Art Unit 2173	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,751,373	05-1998	Ohyama et al.	725/59
*	C	US-5,781,247	07-1998	Wehmeyer et al.	348/569
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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